

## FEATURES

- Improved Direct Replacement for AD7545A and AD7545
- DNL and INL Over Temperature:  $\pm 0.5$ LSB
- Gain Error:  $\pm 1$ LSB Maximum
- 4-Quadrant Multiplication
- Single 5V or 15V Supply
- Low Power Consumption
- Low Cost

## APPLICATIONS

- Process Control and Industrial Automation
- Software Controlled Gain Adjustment
- Digitally Controlled Filter and Power Supplies
- Automatic Test Equipment

## DESCRIPTION

The LTC<sup>®</sup>7545A is a 12-bit multiplying digital-to-analog converter (DAC) with a microprocessor compatible parallel input. It is a superior pin compatible replacement for the industry standard AD7545A and AD7545. Improvements include better accuracy, better stability over temperature and supply variations and lower sensitivity to output amplifier offset.

This very versatile DAC is useful for 2-quadrant and 4-quadrant multiplying, programmable gain and filtering and single supply noninverting voltage output operation.

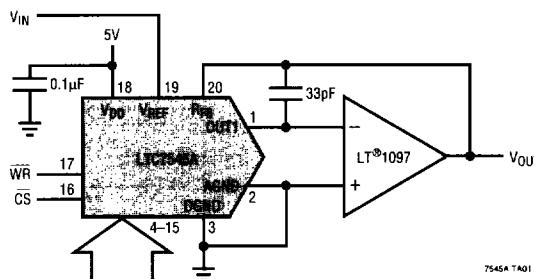
Parts are available in 20-pin PDIP and SO packages and commercial and industrial temperature grades.

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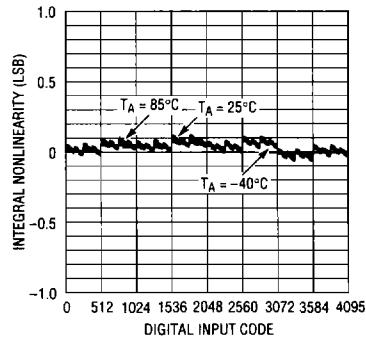
## TYPICAL APPLICATION

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2-Quadrant Multiplying DAC Has Less Than  
0.5LSB (Typ) Total Unadjusted Error



Integral Nonlinearity Over Temperature



7545A TA02

**ABSOLUTE MAXIMUM RATINGS**

V <sub>DD</sub> to AGND .....	-0.5V to 17V
V <sub>DD</sub> to DGND .....	-0.5V to 17V
AGND to DGND .....	-0.5V to V <sub>DD</sub> + 0.5V
DGND to AGND .....	-0.5V to V <sub>DD</sub> + 0.5V
V <sub>REF</sub> to AGND, DGND .....	±25V
R <sub>FB</sub> to AGND, DGND .....	±25V
Digital Inputs to DGND .....	-0.5V to V <sub>DD</sub> + 0.5V
V <sub>OUT1</sub> to AGND, DGND .....	-0.5V to V <sub>DD</sub> + 0.5V
Maximum Junction Temperature .....	150°C
Operating Temperature Range	
Commercial (K, L Versions) .....	0°C to 70°C
Industrial (B, C Versions) .....	-40°C to 85°C
Storage Temperature Range .....	-65°C to 150°C
Lead Temperature (Soldering, 10 sec) .....	300°C

**PACKAGE/ORDER INFORMATION**

TOP VIEW		ORDER PART NUMBER
OUT1	1	20 R <sub>FB</sub>
AGND	2	19 V <sub>REF</sub>
DGND	3	18 V <sub>DD</sub>
DB11 (MSB)	4	17 WR
DB10	5	16 CS
DB9	6	15 D <sub>B</sub> 0 (LSB)
DB8	7	14 DB1
DB7	8	13 DB2
DB6	9	12 DB3
DB5	10	11 DB4
N PACKAGE 20-LEAD PDIP		SW PACKAGE 20-LEAD PLASTIC SO WIDE
T <sub>JMAX</sub> = 150°C, θ <sub>JA</sub> = 100°C/W (N)		
T <sub>JMAX</sub> = 150°C, θ <sub>JA</sub> = 130°C/W (SW)		

Consult factory for Military grade parts.

**ELECTRICAL CHARACTERISTICS**V<sub>DD</sub> = 5V or 15V, V<sub>REF</sub> = 10V, V<sub>OUT1</sub> = AGND = 0V, T<sub>A</sub> = T<sub>MIN</sub> to T<sub>MAX</sub>, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS	LTC7545AK/AB			LTC7545AL/AC			UNITS	
			MIN	TYP	MAX	MIN	TYP	MAX		
<b>Accuracy</b>										
	Resolution		●	12		12			Bits	
INL	Integral Nonlinearity (Relative Accuracy)	(Note 1) T <sub>A</sub> = 25°C T <sub>MIN</sub> to T <sub>MAX</sub>	●		±0.5 ±0.5			±0.5 ±0.5	LSB LSB	
DNL	Differential Nonlinearity	Guaranteed Monotonic T <sub>A</sub> = 25°C T <sub>MIN</sub> to T <sub>MAX</sub>	●		±1 ±1			±0.5 ±0.5	LSB LSB	
GE	Gain Error	(Note 2) T <sub>A</sub> = 25°C T <sub>MIN</sub> to T <sub>MAX</sub>	●		±2 ±3			±1 ±2	LSB LSB	
	Gain Temperature Coefficient	(Note 3) ΔGain/ΔTemperature	●	1	5	1	5		ppm/°C	
I <sub>LKG</sub>	OUT1 Leakage Current	(Note 4) T <sub>A</sub> = 25°C T <sub>MIN</sub> to T <sub>MAX</sub>	●		±10 ±50			±10 ±50	nA nA	
PSRR	Power Supply Rejection		●		±0.002			±0.002	%/%	
<b>Reference Input</b>										
R <sub>REF</sub>	V <sub>REF</sub> Input Resistance	(Note 5)	●	8	11	15	8	11	15	kΩ
<b>AC Performance</b>										
	Output Current Settling Time	(Notes 3, 6, 7)	●		1		1		μs	
	Propagation Delay	(Notes 3, 6, 8)	●		150		150		ns	
	Digital-to-Analog Glitch Impulse	(Notes 6, 9)	●		5		5		nV·sec	
	Multiplying Feedthrough Error	V <sub>REF</sub> = ±10V, 10kHz Sine Wave	●		5		5		mV <sub>P-P</sub>	
<b>Analog Outputs</b>										
C <sub>OUT</sub>	Output Capacitance (Note 3)	DB0 to DB11 = 0V, C <sub>OUT1</sub> WR, CS = 0V	●	30	70	30	70		pF	
		DB0 to DB11 = V <sub>DD</sub> , C <sub>OUT1</sub> WR, CS = 0V	●	60	150	60	150		pF	

**ELECTRICAL CHARACTERISTICS** $V_{DD} = 5V$ ,  $V_{REF} = 10V$ ,  $V_{OUT1} = AGND = 0V$ ,  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS	ALL GRADES			UNITS	
			MIN	TYP	MAX		
<b>Digital Inputs</b>							
$V_{IH}$	Digital Input High Voltage		●	2.4		V	
$V_{IL}$	Digital Input Low Voltage		●		0.8	V	
$I_{IN}$	Digital Input Current		●	0.001	$\pm 1$	$\mu A$	
$C_{IN}$	Digital Input Capacitance	(Note 3) $V_{IN} = 0V$	●		8	pF	
<b>Timing Characteristics (Note 3)</b>							
$t_{CS}$	CS to WR Setup Time		●	100		ns	
$t_{CH}$	CS to WR Hold Time		●	0		ns	
$t_{WR}$	Write Pulse Width		●	100		ns	
$t_{DS}$	Data Setup Time		●	100		ns	
$t_{DH}$	Data Hold Time		●	5		ns	
<b>Power Supply</b>							
$V_{DD}$	Supply Voltage		●	4.75	5	5.25	V
$I_{DD}$	Supply Current	All Digital Inputs = $V_{IH}$ or $V_{IL}$ All Digital Inputs = 0V or $V_{DD}$	●		2		$mA$
			●	10	100		$\mu A$

 $V_{DD} = 15V$ ,  $V_{REF} = 10V$ ,  $V_{OUT1} = AGND = 0V$ ,  $T_A = T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

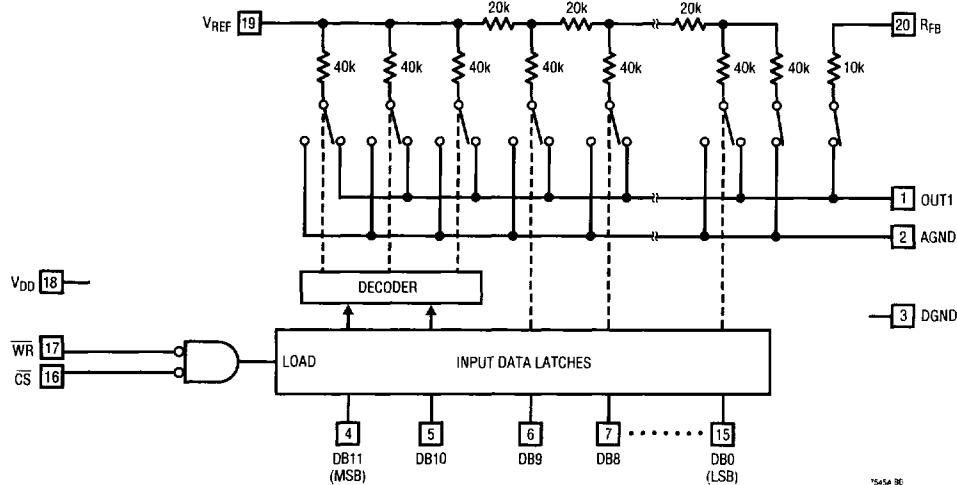
SYMBOL	PARAMETER	CONDITIONS	ALL GRADES			UNITS	
			MIN	TYP	MAX		
<b>Digital Inputs</b>							
$V_{IH}$	Digital Input High Voltage		●	13.5		V	
$V_{IL}$	Digital Input Low Voltage		●		1.5	V	
$I_{IN}$	Digital Input Current		●		$\pm 1$	$\mu A$	
$C_{IN}$	Digital Input Capacitance	(Note 3) $V_{IN} = 0V$	●		8	pF	
<b>Timing Characteristics (Note 3)</b>							
$t_{CS}$	CS to WR Setup Time		●	75		ns	
$t_{CH}$	CS to WR Hold Time		●	0		ns	
$t_{WR}$	Write Pulse Width		●	75		ns	
$t_{DS}$	Data Setup Time		●	60		ns	
$t_{DH}$	Data Hold Time		●	5		ns	
<b>Power Supply</b>							
$V_{DD}$	Supply Voltage		●	14.25	15	15.75	V
$I_{DD}$	Supply Current	All Digital Inputs = $V_{IH}$ or $V_{IL}$ All Digital Inputs = 0V or $V_{DD}$	●		2		$mA$
			●	10	100		$\mu A$

The ● denotes specifications which apply over the full operating temperature range.

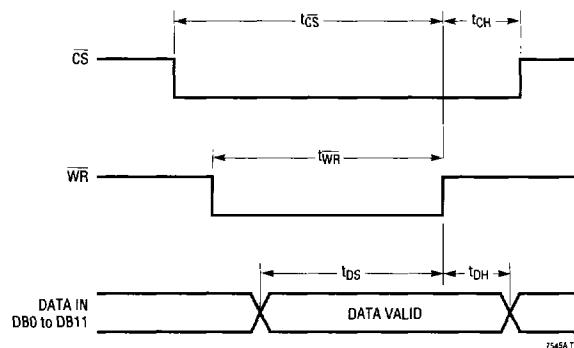
**Note 1:**  $\pm 0.5LSB = \pm 0.012\%$  of full scale.**Note 2:** Using internal feedback resistor.**Note 3:** Guaranteed by design, not subject to test.**Note 4:**  $I_{OUT1}$  with DAC register loaded to all 0s.**Note 5:** Typical temperature coefficient is 100ppm/ $^{\circ}C$ .**Note 6:** OUT1 load =  $100\Omega$  in parallel with 13pF.**Note 7:** To 0.01% for a full-scale change, measured from the falling edge of WR, CS = 0V.**Note 8:** From digital input change to 90% of final analog output.**Note 9:**  $V_{REF} = 0V$ . DAC register contents changed from all 0s to all 1s or all 1s to all 0s.

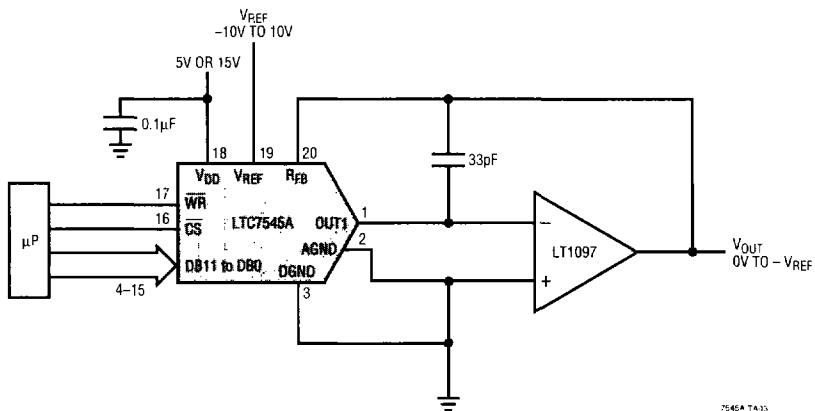
# LTC7545A

## BLOCK DIAGRAM



## TIMING DIAGRAM



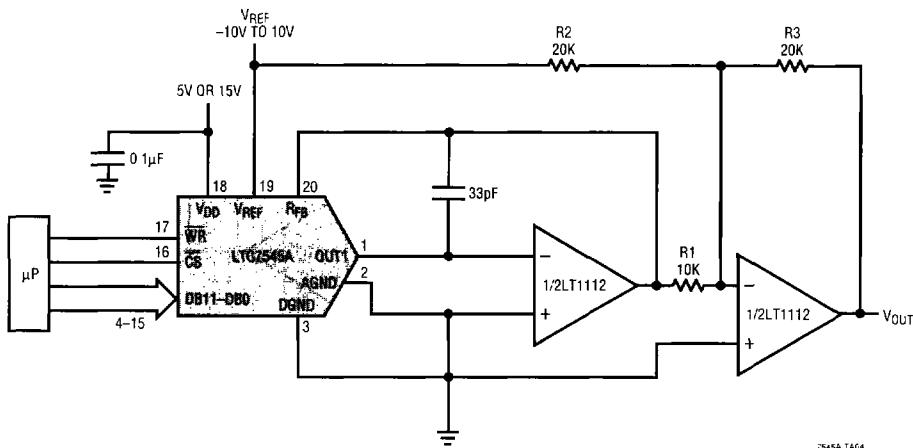
**TYPICAL APPLICATIONS****Unipolar Operation (2-Quadrant Multiplication)**

7545A TA35

**Table 1. Unipolar Binary Code Table**

DIGITAL INPUT BINARY NUMBER IN DAC LATCH			ANALOG OUTPUT V <sub>OUT</sub>
MSB	LSB		
1111	1111	1111	-V <sub>REF</sub> (4095/4096)
1000	0000	0000	-V <sub>REF</sub> (2048/4096) = -V <sub>REF</sub> /2
0000	0000	0001	-V <sub>REF</sub> (1/4096)
0000	0000	0000	0V

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**TYPICAL APPLICATIONS****Bipolar Operation (4-Quadrant Multiplication)****Table 2. Bipolar Offset Binary Code Table**

DIGITAL INPUT BINARY NUMBER IN DAC LATCH		ANALOG OUTPUT $V_{OUT}$
MSB	LSB	
1111	1111	$V_{REF}$ (2047/2048)
1000	0000	$V_{REF}$ (1/2048)
1000	0000	0V
0111	1111	$-V_{REF}$ (1/2048)
0000	0000	$-V_{REF}$ (2048/2048) = $-V_{REF}$

**RELATED PARTS**

PART NUMBER	DESCRIPTION	COMMENTS
LTC1257	Complete Serial I/O $V_{OUT}$ 12-Bit DAC	5V to 15V Single Supply in 8-Pin SO and PDIP
LTC1450/LTC1450L	Complete Parallel Input $V_{OUT}$ 12-Bit DACs	Rail-to-Rail $V_{OUT}$ , 3V/5V Single Supply, 12-Bit or (8 + 4) Bit Loading
LTC1451/LTC1452/LTC1453	Complete Serial I/O $V_{OUT}$ 12-Bit DACs	Rail-to-Rail $V_{OUT}$ . 3V/5V Single Supply in 8-Pin SO and PDIP
LTC7541A	Parallel I/O Multiplying $I_{OUT}$ 12-Bit DAC	12-Bit Wide Parallel Input
LTC7543/LTC8143	Serial I/O Multiplying $I_{OUT}$ 12-Bit DACs	Clear Pin and Serial Data Output (LTC8143)
LTC8043	Serial I/O Multiplying $I_{OUT}$ 12-Bit DAC	8-Pin SO and PDIP